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SEMICONDUCTOR MATERIAL AND DEVICE ... MATERIAL AND DEVICE CHARACTERIZATION DIETER K.

SCHRÖDER Arizona State University ... 3.2 Metal-Semiconductor Contacts, 100 3.3 Contact Resistance, 104 3.4 Measurement Techniques, 109 3.5 Schottky Barrier Height, 130 3.6 Strengths And Weaknesses,

137 Appendix 3.1 Alloys For Contacts To  
Semiconductor Materials, 139 References, 139 4.  
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iii 3th, 2024.

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